

Notice of References Cited	Application/Control No. 10/604,171	Applicant(s)/Patent Under Reexamination WU, CHIUNG-LUN	
	Examiner Shih-wen Hsieh	Art Unit 2861	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US- 5,663,751	09-1997	Halbrook	347/22
	B	US-			
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	E	US-			
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	K	US-			
	L	US-			
	M	US-			

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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